Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/632,570	LIAW, JHON-JHY	
Examiner	Art Unit	
Lan Vinh	1765	

SEARCHED					
Class	Subclass	Date	Examiner		
438	404, 410, 706,710,7 18,	8/14/2007	LV		
438	412,424,42	8/14/2007	LV		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
438	404,410	8/14/2007	LV		
438	706,718	8/14/2007	LV		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
interference search history printout	8/14/2007	LV		